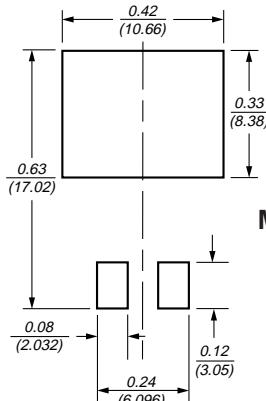
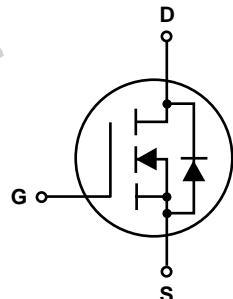
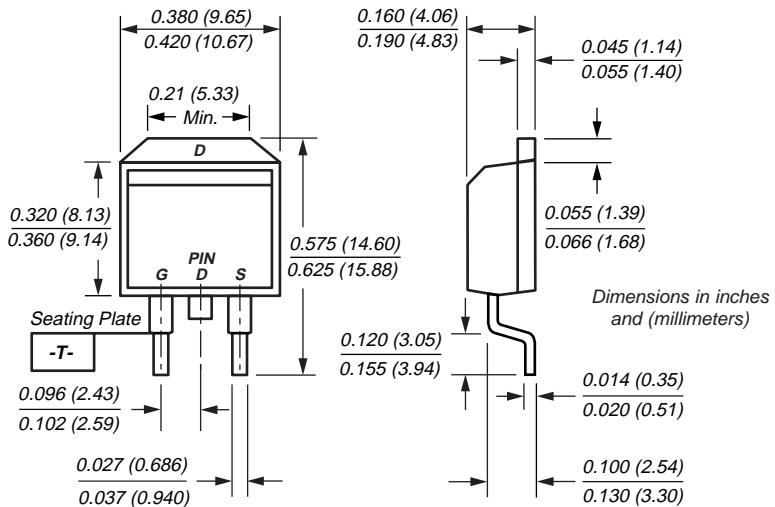




**TRENCH  
GENFET®**

TO-263AB



## Mechanical Data

**Case:** JEDEC TO-263 molded plastic body

**Terminals:** Leads solderable per MIL-STD-750, Method 2026

**High temperature soldering guaranteed:**  
250°C/10 seconds at terminals

**Mounting Position:** Any    **Weight:** 1.3g

## Features

- Advanced Trench Process Technology
  - High Density Cell Design for Ultra Low On-Resistance
  - Specially Designed for Low Voltage DC/DC Converters
  - Fast Switching for High Efficiency

## Maximum Ratings and Thermal Characteristics ( $T_C = 25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V <sub>D</sub> S	30	V
Gate-Source Voltage	V <sub>G</sub> S	±20	
Continuous Drain Current <sup>(1)</sup>	I <sub>D</sub>	50	A
Pulsed Drain Current	I <sub>DM</sub>	100	
Maximum Power Dissipation	T <sub>c</sub> = 25°C T <sub>c</sub> = 100°C	P <sub>D</sub> 62.5 25	W
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	°C
Lead Temperature (1/8" from case for 5 sec.)	T <sub>L</sub>	275	°C
Junction-to-Case Thermal Resistance	R <sub>θJC</sub>	2.0	°C/W
Junction-to-Ambient Thermal Resistance <sup>(2)</sup>	R <sub>θJA</sub>	40	°C/W

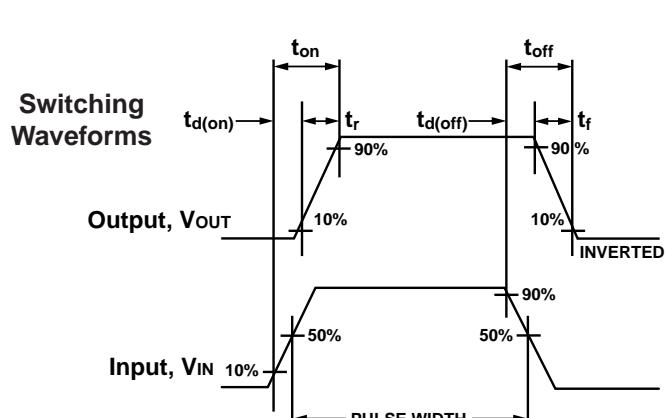
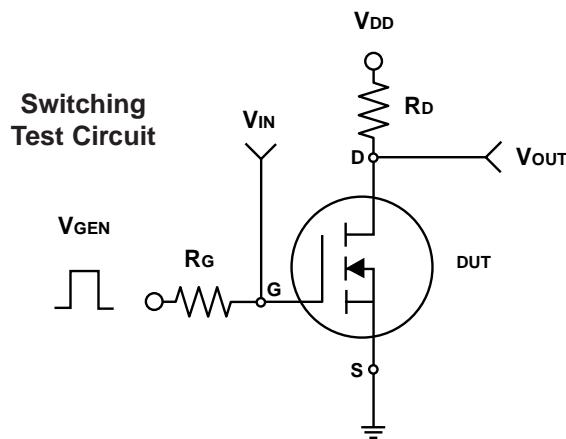
**Notes:** (1) Maximum DC current limited by the package  
(2) 1-in<sup>2</sup> 2oz. Cu PCB mounted

**N-Channel Enhancement-Mode MOSFET**
**Electrical Characteristics** ( $T_J = 25^\circ\text{C}$  unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
<b>Static</b>						
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	$\text{V}_{\text{GS}} = 0\text{V}, \text{I}_D = 250\mu\text{A}$	30			V
Gate Threshold Voltage	$\text{V}_{\text{GS(th)}}$	$\text{V}_{\text{DS}} = \text{V}_{\text{GS}}, \text{I}_D = 250\mu\text{A}$	1.0		3.0	
Gate-Body Leakage	$\text{I}_{\text{GSS}}$	$\text{V}_{\text{DS}} = 0\text{V}, \text{V}_{\text{GS}} = \pm 20\text{V}$			$\pm 100$	nA
Zero Gate Voltage Drain Current	$\text{I}_{\text{DSS}}$	$\text{V}_{\text{DS}} = 30\text{V}, \text{V}_{\text{GS}} = 0\text{V}$			1	$\mu\text{A}$
On-State Drain Current <sup>(1)</sup>	$\text{I}_{\text{D(on)}}$	$\text{V}_{\text{DS}} \geq 5\text{V}, \text{V}_{\text{GS}} = 10\text{V}$	60			A
Drain-Source On-State Resistance <sup>(1)</sup>	$\text{R}_{\text{DS(on)}}$	$\text{V}_{\text{GS}} = 10\text{V}, \text{I}_D = 25\text{A}$		11	13	$\text{m}\Omega$
		$\text{V}_{\text{GS}} = 4.5\text{V}, \text{I}_D = 20\text{A}$		15	20	
Forward Transconductance <sup>(1)</sup>	$\text{g}_{\text{fs}}$	$\text{V}_{\text{DS}} = 10\text{V}, \text{I}_D = 25\text{A}$		40		S
Diode Forward Voltage	$\text{V}_{\text{SD}}$	$\text{I}_S = 25\text{A}, \text{V}_{\text{GS}} = 0\text{V}$		0.9	1.3	V
<b>Dynamic<sup>(1)</sup></b>						
Total Gate Charge	$\text{Q}_g$	$\text{V}_{\text{DS}} = 15\text{V}, \text{V}_{\text{GS}} = 5\text{V}, \text{I}_D = 50\text{A}$		16	22	nC
Gate-Source Charge	$\text{Q}_{\text{gs}}$	$\text{V}_{\text{DS}} = 15\text{V}, \text{V}_{\text{GS}} = 10\text{V}$ $\text{I}_D = 50\text{A}$		35	60	
Gate-Drain Charge	$\text{Q}_{\text{gd}}$			8		
Turn-On Delay Time	$\text{t}_{\text{d(on)}}$			6		
Rise Time	$\text{t}_r$	$\text{V}_{\text{DD}} = 15\text{V}, \text{R}_L = 15\Omega$ $\text{I}_D \approx 1\text{A}, \text{V}_{\text{GEN}} = 10\text{V}$ $\text{R}_G = 6\Omega$		11	20	ns
Turn-Off Delay Time	$\text{t}_{\text{d(off)}}$			11	20	
Fall Time	$\text{t}_f$			48	80	
Input Capacitance	$\text{C}_{\text{iss}}$			15	30	
Output Capacitance	$\text{C}_{\text{oss}}$	$\text{V}_{\text{DS}} = 15\text{V}$ $f = 1.0\text{MHz}$		1850	—	pF
Reverse Transfer Capacitance	$\text{C}_{\text{rss}}$			315	—	
Source-Drain Reverse Recovery Time	$\text{t}_{\text{rr}}$	$\text{I}_F = 25\text{A}, \frac{\text{d}i}{\text{d}t} = 100\text{A}/\mu\text{s}$		145	—	
				160		ns

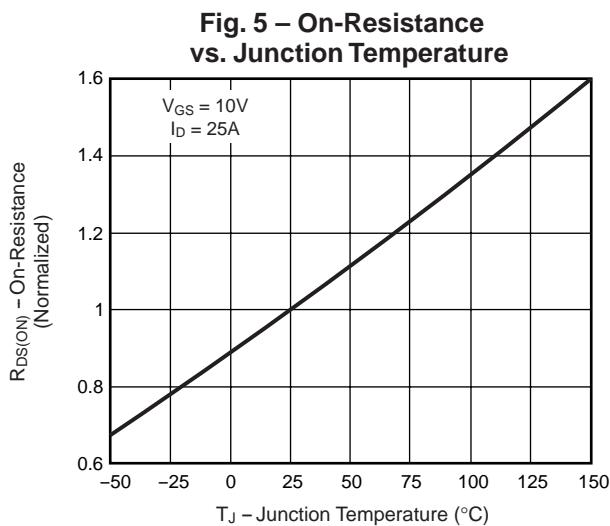
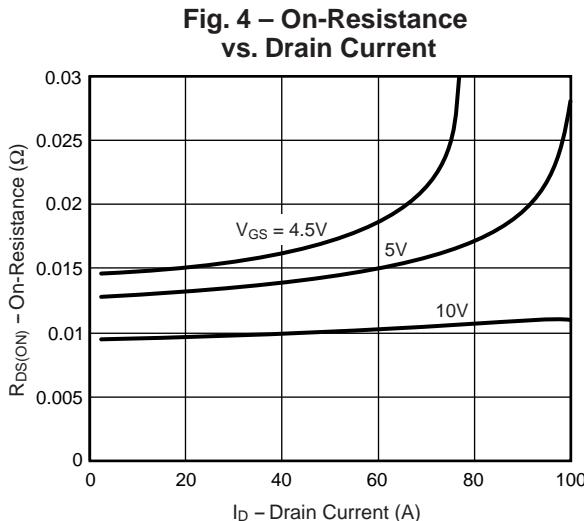
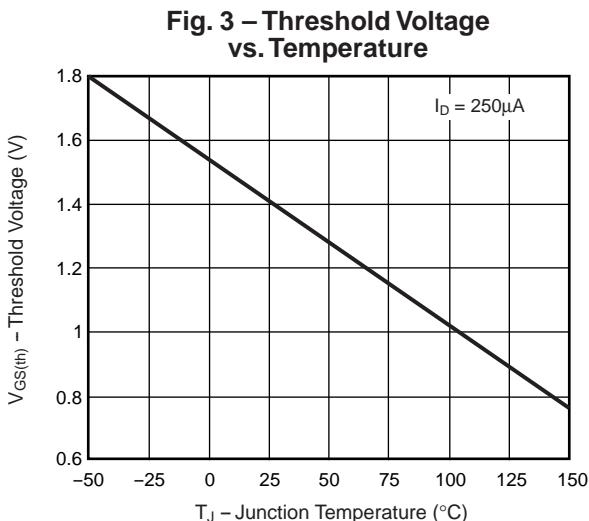
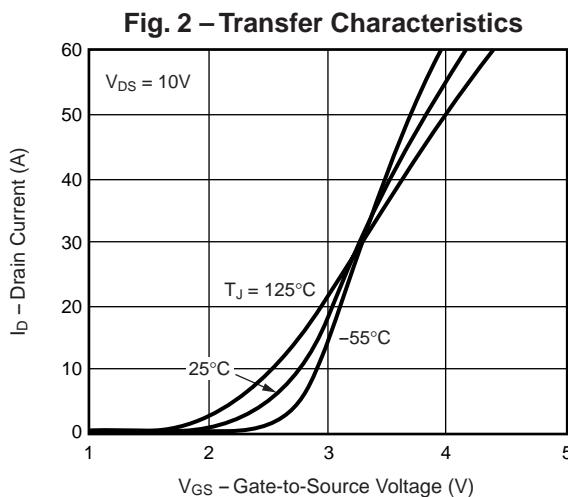
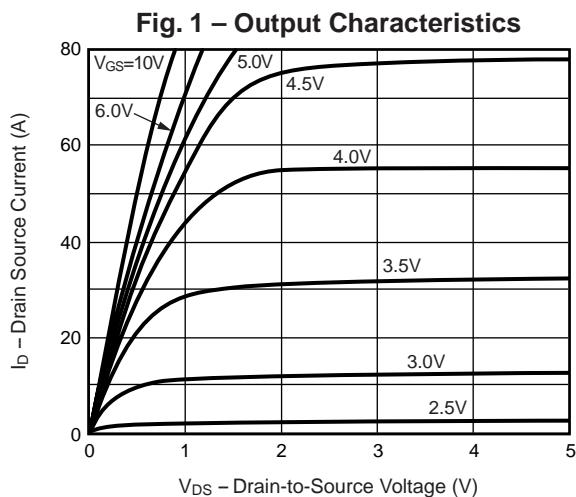
**Note:**

(1) Pulse test; pulse width  $\leq 300\ \mu\text{s}$ , duty cycle  $\leq 2\%$



## N-Channel Enhancement-Mode MOSFET

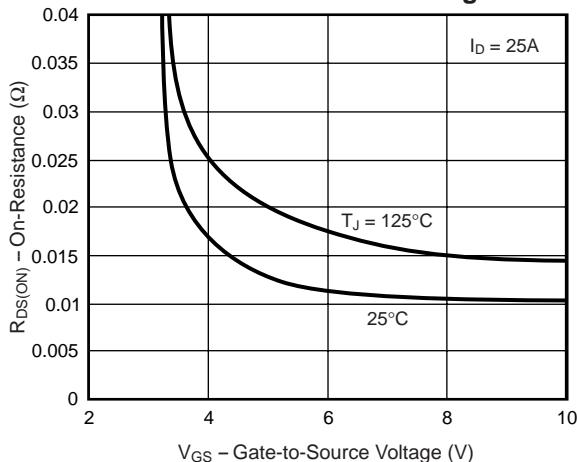
### Ratings and Characteristic Curves (TA = 25°C unless otherwise noted)



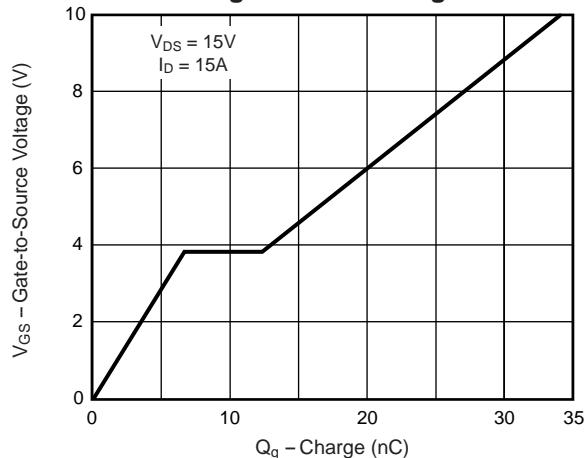
## N-Channel Enhancement-Mode MOSFET

### Ratings and Characteristic Curves ( $T_A = 25^\circ\text{C}$ unless otherwise noted)

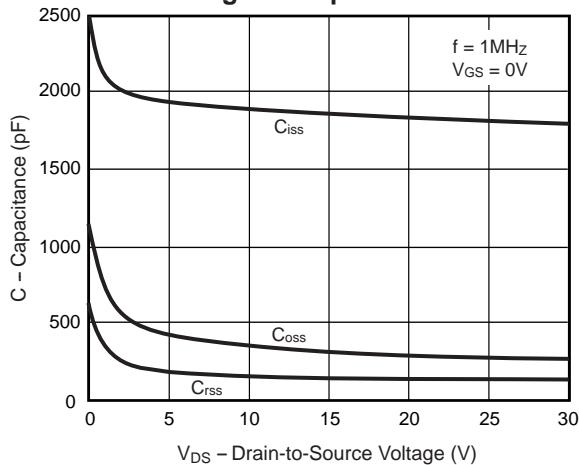
**Fig. 6 – On-Resistance  
vs. Gate-to-Source Voltage**



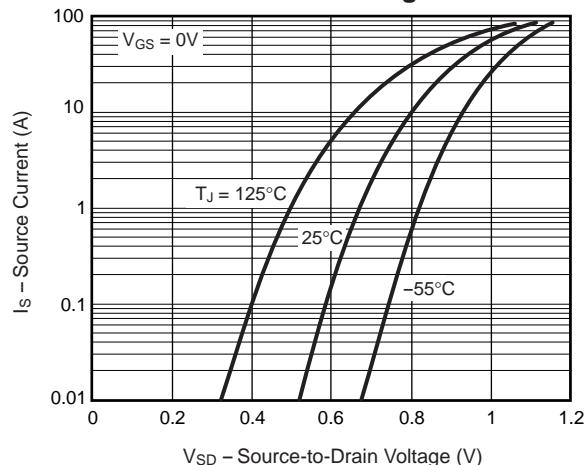
**Fig. 7 – Gate Charge**



**Fig. 8 – Capacitance**



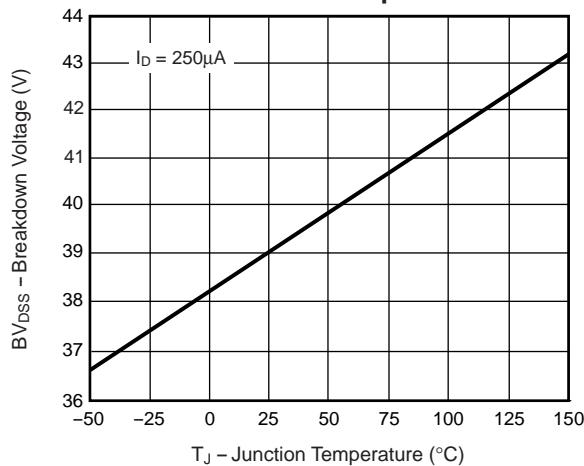
**Fig. 9 – Source-Drain Diode Forward Voltage**



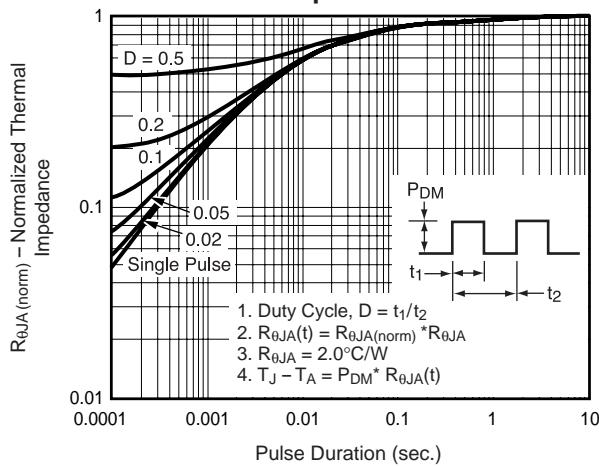
## N-Channel Enhancement-Mode MOSFET

### Ratings and Characteristic Curves ( $T_A = 25^\circ\text{C}$ unless otherwise noted)

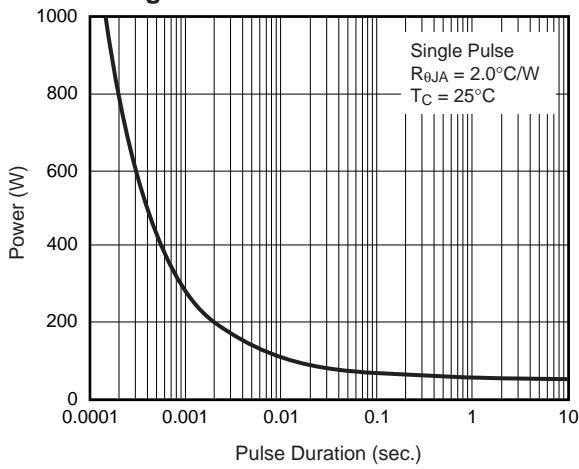
**Fig. 10 – Breakdown Voltage vs. Junction Temperature**



**Fig. 11 – Transient Thermal Impedance**



**Fig. 12 – Power vs. Pulse Duration**



**Fig. 13 – Maximum Safe Operating Area**

